

Search Notes

Application/Control No.

10/775,983

Examiner

Ahshik Kim

Applicant(s)/Patent under
Reexamination

MEIER ET AL.

Art Unit

2876

SEARCHED

Class	Subclass	Date	Examiner
235	462.25	9/28/2005	AK
↓	462.26	↓	↓
↓	462.24	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	9/28/2005	AK